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Environmental testing –

Part 2-21: Tests – Test U: Robustness of terminations and integral mounting devices

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INTERNATIONAL ELECTROTECHNICAL COMMISSION

ENVIRONMENTAL TESTING –

Part 2-21: Tests – Test U: Robustness of terminations and integral mounting devices

FOREWORD

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International Standard IEC 60068-2-21 has been prepared by IEC technical committee 91: Electronics assembly technology.

This sixth edition cancels and replaces the fifth edition, published in 1999, and constitutes a technical revision.

This edition includes the following significant technical changes with respect to the previous edition

- Addition of torque severity for nominal thread diameter of 8 mm in Test Ud: torque in accordance with IEC 60252-2 (see table 5)
- Modification of substrate specification and mounting method describing lead-free solder in Test Ue (see Figure 5 and 8.3.3 et al.)

- Modification of test jig and test condition in Test Ue₁: substrate bending test (see Figure 7 et al.)
- Change of pushing force from 10 N to 5 N in Test Ue₃: shear test (see 8.5.3.2)

The text of this standard is based on the following documents:

FDIS	Report on voting
91/582/FDIS	91/607/RVD

Full information on the voting for the approval of this standard can be found in the report on voting indicated in the above table.

This publication has been drafted in accordance with the ISO/IEC Directives, Part 2.

A complete list of all parts comprising the IEC 60068 series, under the general title *Environmental testing*, can be found on the IEC website.

The committee has decided that the contents of this publication will remain unchanged until the maintenance result date indicated on the IEC web site under "<http://webstore.iec.ch>" in the data related to the specific publication. At this date, the publication will be

- reconfirmed;
- withdrawn;
- replaced by a revised edition, or
- amended.

A bilingual version of this publication may be issued at a later date.

ENVIRONMENTAL TESTING –

Part 2-21: Tests – Test U: Robustness of terminations and integral mounting devices

1 Scope

This part of IEC 60068 is applicable to all electrical and electronic components whose terminations or integral mounting devices are liable to be submitted to stresses during normal assembly or handling operations.

Table 1 provides details of the applicable tests.

Table 1 – Application

Test	Type	Component	Mounted/not mounted
Ua ₁	Tensile	Leaded devices	Not mounted
Ua ₂	Thrust	Leaded devices	Not mounted
Ub	Bending	Leaded devices	Not mounted
Uc	Torsion	Leaded devices	Not mounted
Ud	Torque	Threaded stud or screw termination	Not mounted
Ue ₁	Bending	Surface mounted devices	Mounted
Ue ₂	Pull/push	Surface mounted devices	Mounted
Ue ₃	Shear	Surface mounted devices	Mounted

2 Normative references

The following referenced documents are indispensable for the application of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

IEC 60068-1:1988, *Environmental testing – Part 1: General and guidance*
Amendment 1 (1992)

IEC 60068-2-20:1979, *Environmental testing – Part 2: Tests – Test T: Soldering*
Amendment 2 (1987)

IEC 60068-2-58:2004, *Environmental testing – Part 2-58: Tests – Test Td – Test methods for solderability, resistance to dissolution of metallization and to soldering heat of surface mounting devices (SMD)*

IEC 60068-2-61:1991, *Environmental testing – Part 2: Tests – Test Z/ABDM: Climatic sequence*

IEC 61249-2-7:2002, *Materials for printed boards and other interconnecting structures – Part 2-7: Reinforced base materials clad and unclad – Epoxide woven E-glass laminated sheet of defined flammability (vertical burning test), copper-clad*

IEC 61188-5 (all parts), *Printed boards and printed board assemblies – Design and use*

IEC 61190-1-2:2002, *Attachment materials for electronic assembly – Part 1-2: Requirements for soldering pastes for high quality interconnections in electronics assembly*

IEC 61191-2:1998, *Printed board assemblies – Part 2: Sectional specification – Requirements for surface mount soldered assemblies*

ISO 272:1982, *Fasteners – Hexagon products – Widths across flats*

ISO 9453:1990, *Soft solder alloys – Chemical compositions and forms*